

WEST

Freeform Search

Database: US Patents Full-Text Database US Pre-Grant Publication Full-Text Database JPO Abstracts Database EPO Abstracts Database Derwent World Patents Index IBM Technical Disclosure Bulletins

Term:

Display: **Documents in Display Format:** CIT Starting with Number

Generate: Hit List Hit Count Image

Search History

Today's Date: 1/15/2002

<u>DB Name</u>	<u>Query</u>	<u>Hit Count</u>	<u>Set Name</u>
USPT,PGPB	I8 and I4	5	L9
USPT,PGPB	I1 and ((216/59 or 216/79 or 216/80 or 438/14 or 438/723).ccls.)	569	L8
USPT,PGPB	I4 same (fluoro carbon or "C.sub.4 F.sub.8")	4	L7
USPT,PGPB	I2 and (ratio same (carbon near3 fluorine))	13	L6
USPT,PGPB	I2 and I4	1	L5
USPT,PGPB	I3 same (control\$3 or detect\$3)	2355	L4
USPT,PGPB	(residence time) same gas	10996	L3
USPT,PGPB	I1 same (fluoro carbon or "C.sub.4 F.sub.8")	154	L2
USPT,PGPB	(etch\$3 or coat\$3 or deposit\$3) same (silicon near2 oxide or "Si O.sub.2")	28106	L1